



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



Features

- Pin and function compatible with CY7C1010CV33
- High speed
 - $t_{AA} = 10 \text{ ns}$
- Low active power
 - $I_{CC} = 90 \text{ mA}$ at 10 ns
- Low CMOS standby power
 - $I_{SB2} = 10 \text{ mA}$
- 2.0 V data retention
- Automatic power down when deselected
- TTL-compatible inputs and outputs
- Easy memory expansion with \overline{CE} and \overline{OE} features
- Available in Pb-free 36-pin SOJ and 44-pin TSOP II packages

Functional Description

The CY7C1010DV33 is a high performance CMOS Static RAM organized as 256 K words by 8 bits. Easy memory expansion is provided by an active LOW Chip Enable (\overline{CE}), an active LOW Output Enable (\overline{OE}), and three-state drivers. Writing to the device is accomplished by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. Data on the eight I/O pins (I/O_0 through I/O_7) is then written into the location specified on the address pins (A_0 through A_{17}).

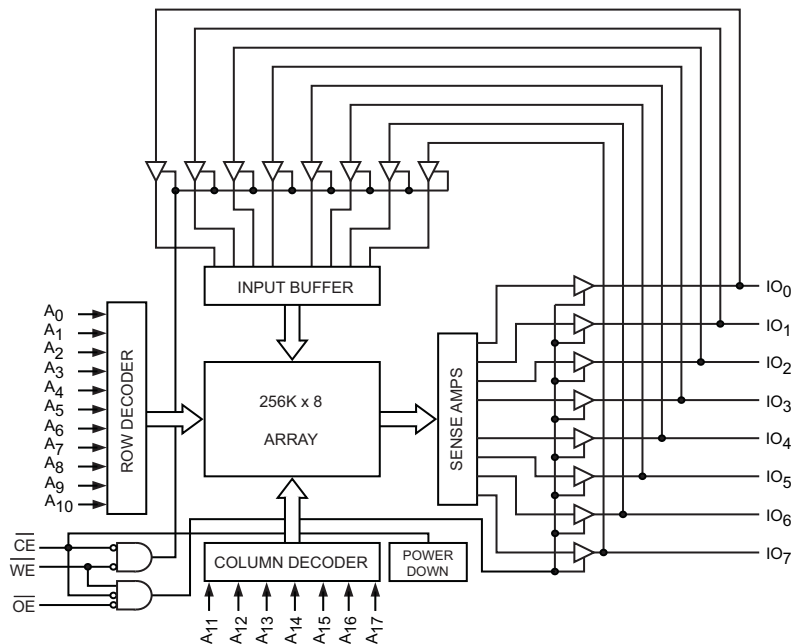
Reading from the device is accomplished by taking Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing Write Enable (\overline{WE}) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

The eight input and output pins (I/O_0 through I/O_7) are placed in a high impedance state when the device is deselected (\overline{CE} HIGH), the outputs are disabled (\overline{OE} HIGH), or during a Write operation (\overline{CE} LOW, and \overline{WE} LOW).

The CY7C1010DV33 is available in 36-pin SOJ and 44-pin TSOP II packages with center power and ground (revolutionary) pinout.

For a complete list of related documentation, [click here](#).

Logic Block Diagram



Contents

| | | | |
|---|-----------|--|-----------|
| Selection Guide | 3 | Ordering Information | 11 |
| Pin Configuration | 3 | Ordering Code Definitions | 11 |
| Maximum Ratings | 4 | Package Diagrams | 12 |
| Operating Range | 4 | Acronyms | 14 |
| Electrical Characteristics | 4 | Document Conventions | 14 |
| Capacitance | 5 | Units of Measure | 14 |
| Thermal Resistance | 5 | Document History Page | 15 |
| AC Test Loads and Waveforms | 5 | Sales, Solutions, and Legal Information | 16 |
| Data Retention Characteristics | 6 | Worldwide Sales and Design Support | 16 |
| Data Retention Waveform | 6 | Products | 16 |
| AC Switching Characteristics | 7 | PSoC® Solutions | 16 |
| Switching Waveforms | 8 | Cypress Developer Community | 16 |
| Truth Table | 10 | Technical Support | 16 |

Selection Guide

| Description | -10 | Unit |
|------------------------------|-----|------|
| Maximum Access Time | 10 | ns |
| Maximum Operating Current | 90 | mA |
| Maximum CMOS Standby Current | 10 | mA |

Pin Configuration

Figure 1. 36-pin SOJ pinout [1]

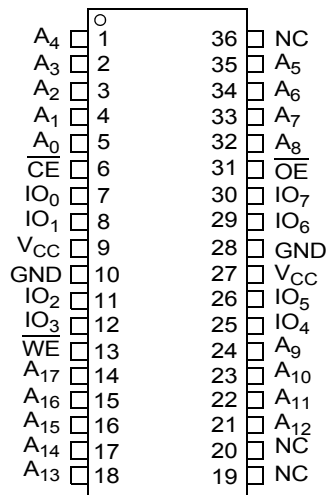
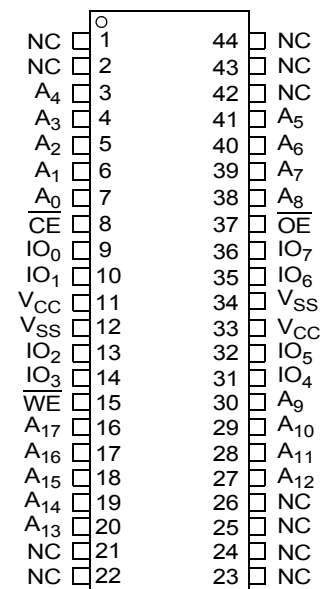


Figure 2. 44-pin TSOP II pinout [1]



Note

1. NC pins are not connected on the die.

Maximum Ratings

Exceeding the maximum ratings may impair the useful life of the device. These user guidelines are not tested.

| | |
|---|-----------------------------------|
| Storage Temperature | -65 °C to +150 °C |
| Ambient Temperature with Power Applied | -55 °C to +125 °C |
| Supply Voltage on V _{CC} Relative to GND [2] | -0.5 V to +4.6 V |
| DC Voltage Applied to Outputs in High Z State [2] | -0.3 V to V _{CC} + 0.3 V |

| | |
|---|-----------------------------------|
| DC Input Voltage [2] | -0.3 V to V _{CC} + 0.3 V |
| Current into Outputs (LOW) | 20 mA |
| Static Discharge Voltage (MIL-STD-883, Method 3015) | > 2001 V |
| Latch Up Current | > 200 mA |

Operating Range

| Range | Ambient Temperature | V _{CC} |
|------------|---------------------|-----------------|
| Industrial | -40 °C to +85 °C | 3.3V ± 0.3V |

Electrical Characteristics

Over the Operating Range

| Parameter | Description | Test Conditions | -10 | | Unit | |
|------------------|---|---|---------|-----------------------|------|----|
| | | | Min | Max | | |
| V _{OH} | Output HIGH Voltage | V _{CC} = Min; I _{OH} = -4.0 mA | 2.4 | - | V | |
| V _{OL} | Output LOW Voltage | V _{CC} = Min; I _{OL} = 8.0 mA | - | 0.4 | V | |
| V _{IH} | Input HIGH Voltage | | 2.0 | V _{CC} + 0.3 | V | |
| V _{IL} | Input LOW Voltage [2] | | -0.3 | 0.8 | V | |
| I _{Ix} | Input Leakage Current | GND ≤ V _I ≤ V _{CC} | -1 | +1 | μA | |
| I _{OZ} | Output Leakage Current | GND ≤ V _{OUT} ≤ V _{CC} , Output Disabled | -1 | +1 | μA | |
| I _{CC} | V _{CC} Operating Supply Current | V _{CC} = Max, f = f _{MAX} = 1/t _{RC} | 100 MHz | - | 90 | mA |
| | | | 83 MHz | - | 80 | |
| | | | 66 MHz | - | 70 | |
| | | | 40 MHz | - | 60 | |
| I _{SB1} | Automatic CE Power-down Current – TTL Inputs | Max V _{CC} , $\overline{CE} \geq V_{IH}$; V _{IN} ≥ V _{IH} or V _{IN} ≤ V _{IL} , f = f _{MAX} | - | 20 | mA | |
| I _{SB2} | Automatic CE Power-down Current – CMOS Inputs | Max V _{CC} , $\overline{CE} \geq V_{CC} - 0.3 V$, V _{IN} ≥ V _{CC} - 0.3 V, or V _{IN} ≤ 0.3 V, f = 0 | - | 10 | mA | |

Note

2. V_{IL} (min.) = -2.0V and V_{IH} (max.) = V_{CC} + 2.0V for pulse durations of less than 20 ns.

Capacitance

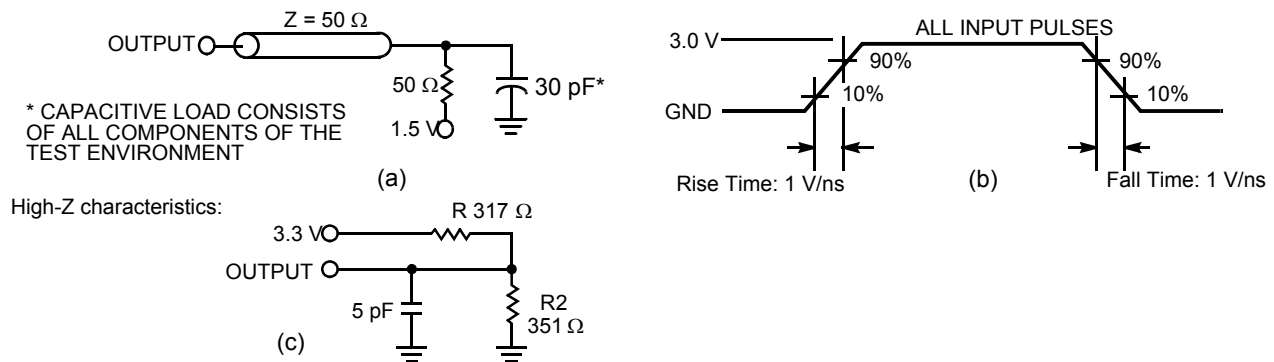
| Parameter ^[3] | Description | Test Conditions | 36-pin SOJ | 44-pin TSOP II | Unit |
|--------------------------|-------------------|--|------------|----------------|------|
| C _{IN} | Input capacitance | T _A = 25 °C, f = 1 MHz, V _{CC} = 3.3 V | 8 | 8 | pF |
| C _{OUT} | I/O capacitance | | 8 | 8 | pF |

Thermal Resistance

| Parameter ^[3] | Description | Test Conditions | 36-pin SOJ | 44-pin TSOP II | Unit |
|--------------------------|--|---|------------|----------------|------|
| Θ _{JA} | Thermal resistance (junction to ambient) | Still air, soldered on a 3 × 4.5 inch, four layer printed circuit board | 59.17 | 50.66 | °C/W |
| Θ _{JC} | Thermal resistance (junction to case) | | 32.63 | 17.77 | °C/W |

AC Test Loads and Waveforms

Figure 3. AC Test Loads and Waveforms ^[4]



Notes

- 3. Tested initially and after any design or process changes that may affect these parameters.
- 4. AC characteristics (except High Z) are tested using the load conditions shown in Figure 3 (a). High-Z characteristics are tested for all speeds using the test load shown in Figure 3 (c).

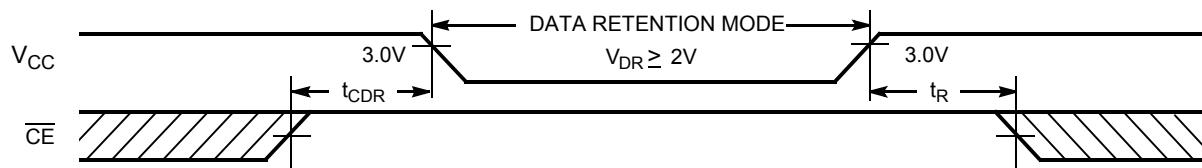
Data Retention Characteristics

Over the Operating Range

| Parameter ^[5] | Description | Conditions | Min | Max | Unit |
|--------------------------|--------------------------------------|--|----------|-----|------|
| V_{DR} | V_{CC} for Data Retention | | 2 | – | V |
| I_{CCDR} | Data Retention Current | $V_{CC} = V_{DR} = 2.0\text{ V}$, $\overline{CE} \geq V_{CC} - 0.3\text{ V}$, $V_{IN} \geq V_{CC} - 0.3\text{ V}$ or $V_{IN} \leq 0.3\text{ V}$ | – | 10 | mA |
| t_{CDR} ^[6] | Chip Deselect to Data Retention Time | | 0 | – | ns |
| t_R ^[7] | Operation Recovery Time | | t_{RC} | – | ns |

Data Retention Waveform

Figure 4. Data Retention Waveform



Notes

- No inputs may exceed $V_{CC} + 0.3\text{ V}$.
- Tested initially and after any design or process changes that may affect these parameters.
- Full device operation requires linear V_{CC} ramp from V_{DR} to $V_{CC(min.)} \geq 50\ \mu\text{s}$ or stable at $V_{CC(min.)} \geq 50\ \mu\text{s}$.

AC Switching Characteristics

Over the Operating Range

| Parameter ^[8] | Description | -10 | | Unit |
|---------------------------------------|--|-----|-----|---------|
| | | Min | Max | |
| Read Cycle | | | | |
| $t_{power}^{[9]}$ | V_{CC} (typical) to the first access | 100 | – | μ s |
| t_{RC} | Read Cycle Time | 10 | – | ns |
| t_{AA} | Address to Data Valid | – | 10 | ns |
| t_{OHA} | Data Hold from Address Change | 3 | – | ns |
| t_{ACE} | \overline{CE} LOW to Data Valid | – | 10 | ns |
| t_{DOE} | \overline{OE} LOW to Data Valid | – | 5 | ns |
| t_{LZOE} | \overline{OE} LOW to Low Z ^[10] | 0 | – | ns |
| t_{HZOE} | \overline{OE} HIGH to High Z ^[10, 11] | – | 5 | ns |
| t_{LZCE} | \overline{CE} LOW to Low Z ^[10] | 3 | – | ns |
| t_{HZCE} | \overline{CE} HIGH to High Z ^[10, 11] | – | 5 | ns |
| t_{PU} | \overline{CE} LOW to Power-up | 0 | – | ns |
| t_{PD} | \overline{CE} HIGH to Power-down | – | 10 | ns |
| Write Cycle^[12, 13] | | | | |
| t_{WC} | Write Cycle Time | 10 | – | ns |
| t_{SCE} | \overline{CE} LOW to Write End | 7 | – | ns |
| t_{AW} | Address Set-up to Write End | 7 | – | ns |
| t_{HA} | Address Hold from Write End | 0 | – | ns |
| t_{SA} | Address Set-up to Write Start | 0 | – | ns |
| t_{PWE} | \overline{WE} Pulse Width | 7 | – | ns |
| t_{SD} | Data Set-up to Write End | 5 | – | ns |
| t_{HD} | Data Hold from Write End | 0 | – | ns |
| t_{LZWE} | \overline{WE} HIGH to Low Z ^[10] | 3 | – | ns |
| t_{HZWE} | \overline{WE} LOW to High Z ^[10, 11] | – | 5 | ns |

Notes

8. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V.
9. t_{POWER} gives the minimum amount of time that the power supply should be at stable, typical V_{CC} values until the first memory access can be performed.
10. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE} , t_{HZOE} is less than t_{LZOE} , and t_{HZWE} is less than t_{LZWE} for any given device.
11. t_{HZOE} , t_{HZCE} , and t_{HZWE} are specified with a load capacitance of 5 pF as in part (d) of Figure 3 on page 5. Transition is measured when the outputs enter a high impedance state.
12. The internal Write time of the memory is defined by the overlap of \overline{CE} LOW, and \overline{WE} LOW. \overline{CE} and \overline{WE} must be LOW to initiate a Write, and the transition of either of these signals can terminate the Write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the Write.
13. The minimum Write cycle time for Write Cycle No. 3 (\overline{WE} controlled, \overline{OE} LOW) is the sum of t_{HZWE} and t_{SD} .

Switching Waveforms

Figure 5. Read Cycle No. 1 [14, 15]

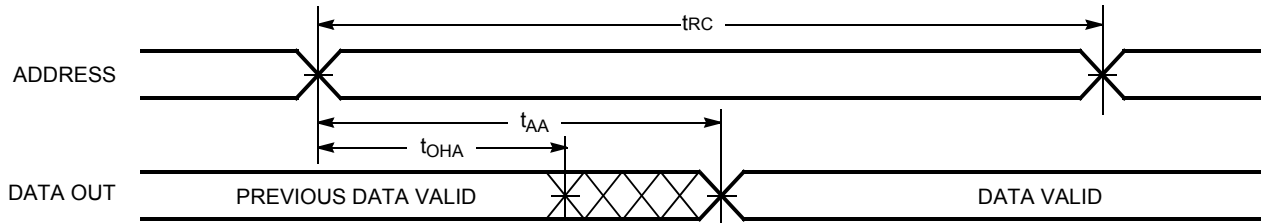
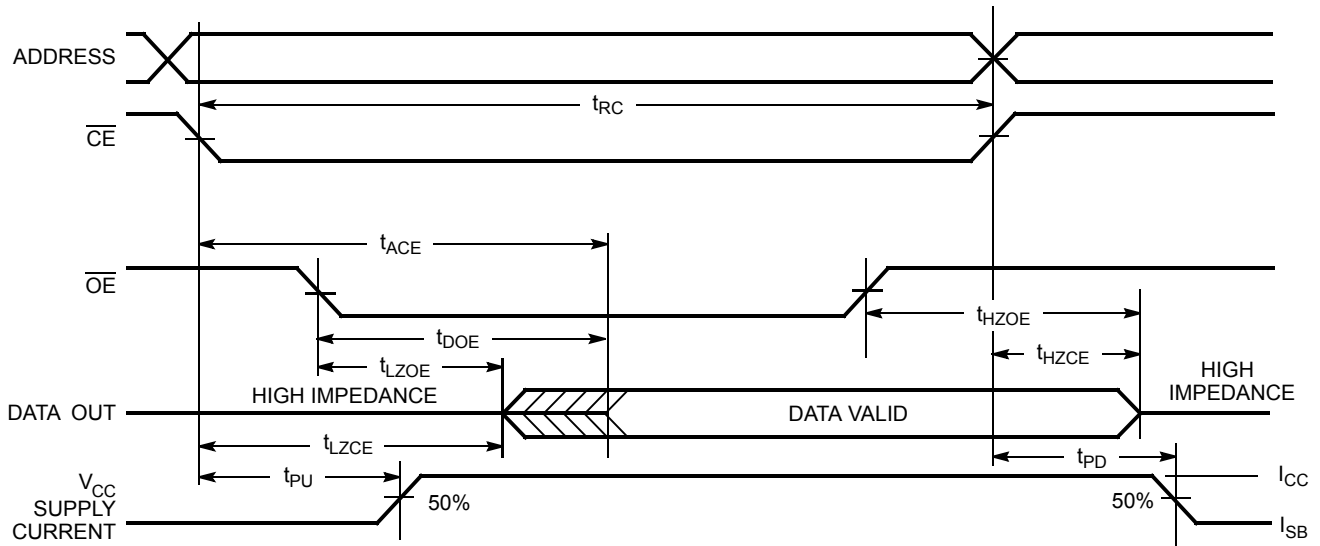


Figure 6. Read Cycle No. 2 (\overline{OE} Controlled) [15, 16]



Notes

- 14. The device is continuously selected. $\overline{OE}, \overline{CE} = V_{IL}$.
- 15. \overline{WE} is HIGH for read cycle.
- 16. Address valid before or similar to \overline{CE} transition LOW.

Switching Waveforms (continued)

Figure 7. Write Cycle No. 1 (\overline{WE} Controlled, \overline{OE} HIGH During Write) [17, 18]

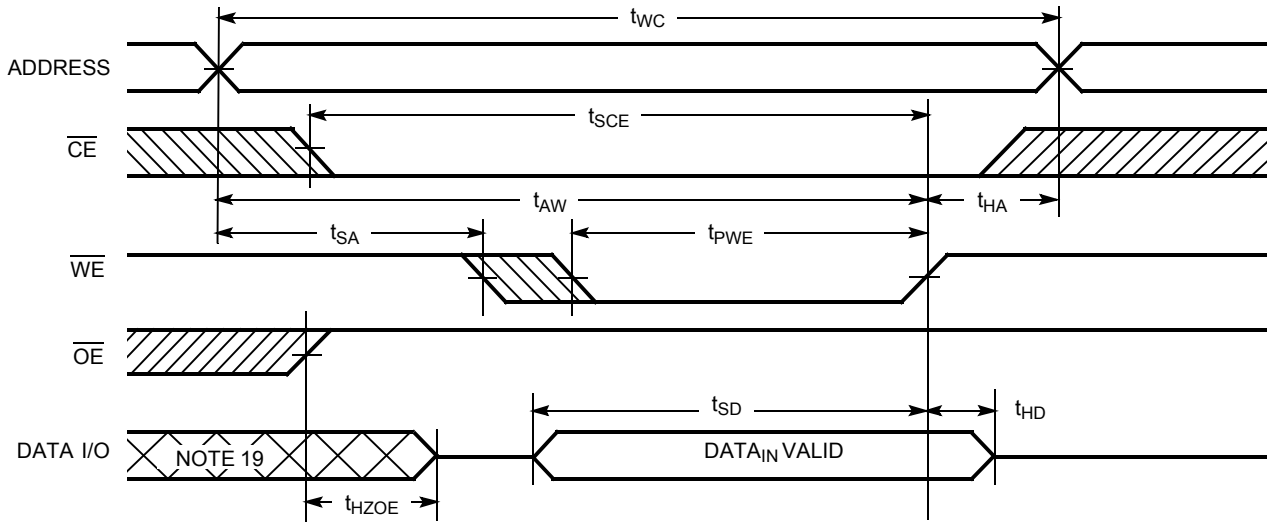
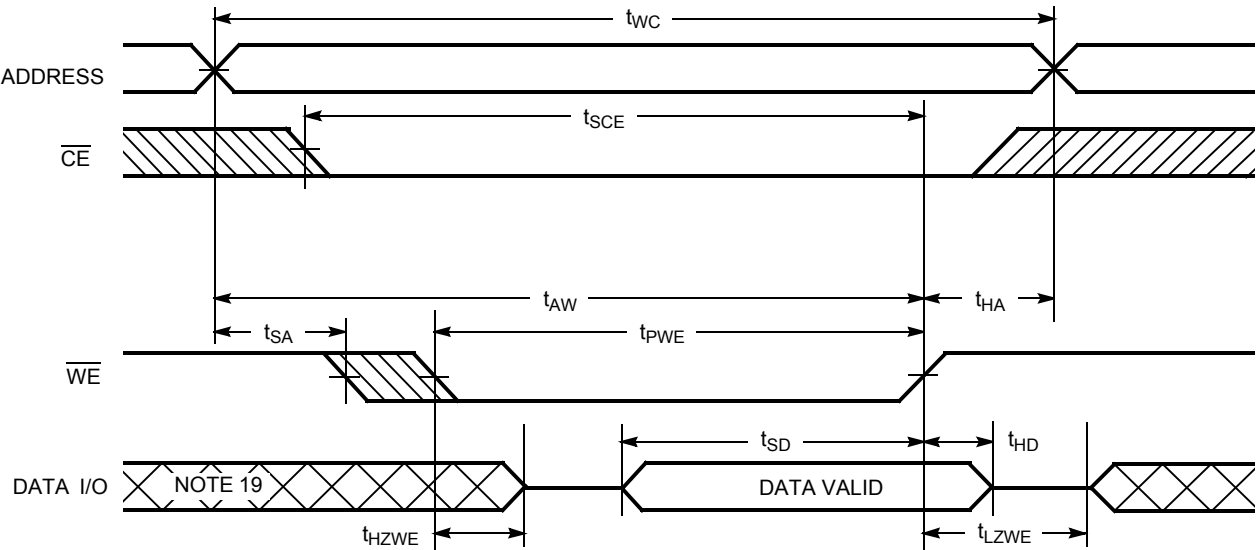


Figure 8. Write Cycle No. 2 (\overline{WE} Controlled, \overline{OE} LOW) [18]



Notes

- 17. Data I/O is high impedance if $\overline{OE} = V_{IH}$.
- 18. If \overline{CE} goes HIGH simultaneously with \overline{WE} going HIGH, the output remains in a high impedance state.
- 19. During this period, the I/Os are in output state and input signals should not be applied.

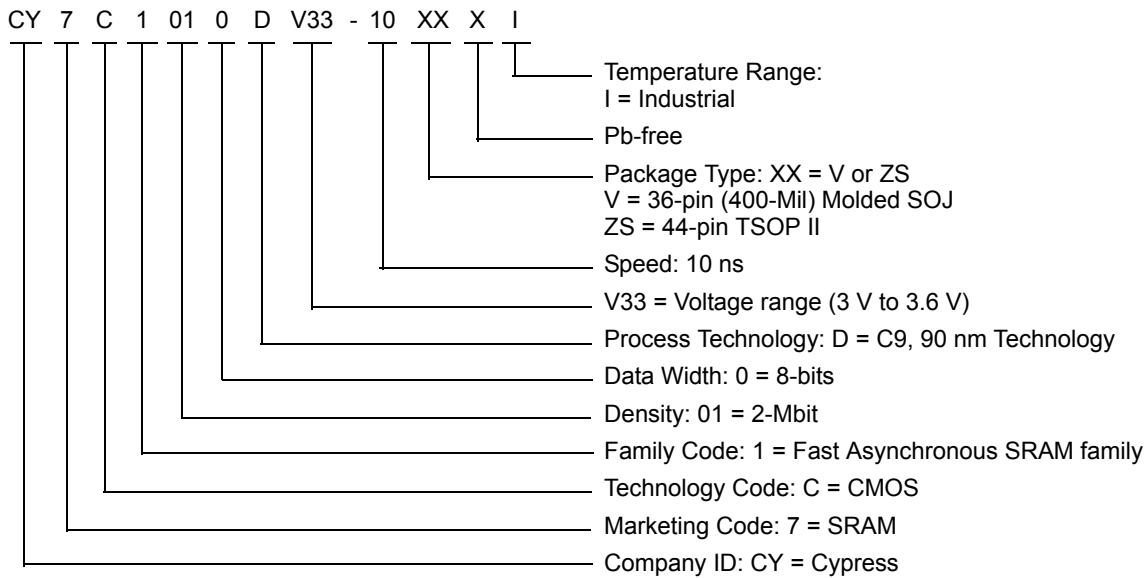
Truth Table

| \overline{CE} | \overline{OE} | \overline{WE} | I/O ₀ -I/O ₇ | I/O ₈ -I/O ₁₅ | Mode | Power |
|-----------------|-----------------|-----------------|------------------------------------|-------------------------------------|----------------------------|----------------------------|
| H | X | X | High Z | High Z | Power Down | Standby (I _{SB}) |
| L | L | H | Data Out | Data Out | Read All Bits | Active (I _{CC}) |
| L | X | L | Data In | Data In | Write All Bits | Active (I _{CC}) |
| L | H | H | High Z | High Z | Selected, Outputs Disabled | Active (I _{CC}) |

Ordering Information

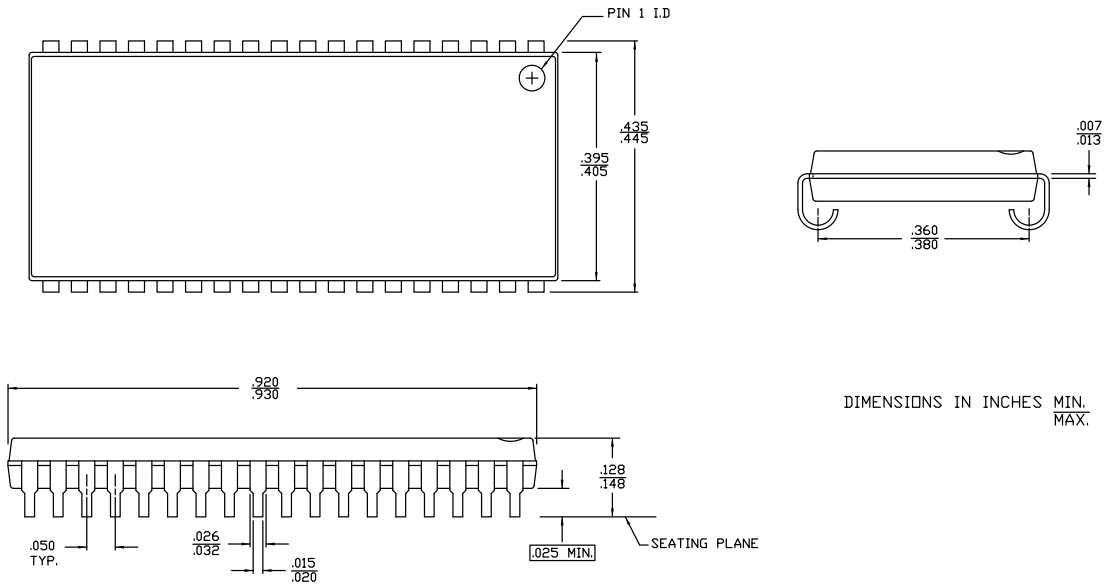
| Speed (ns) | Ordering Code | Package Diagram | Package Type | Operating Range |
|------------|---------------------|-----------------|---------------------------------------|-----------------|
| 10 | CY7C1010DV33-10VXI | 51-85090 | 36-pin (400-Mil) Molded SOJ (Pb-free) | Industrial |
| | CY7C1010DV33-10ZSXI | 51-85087 | 44-pin TSOP II (Pb-free) | |

Ordering Code Definitions



Package Diagrams

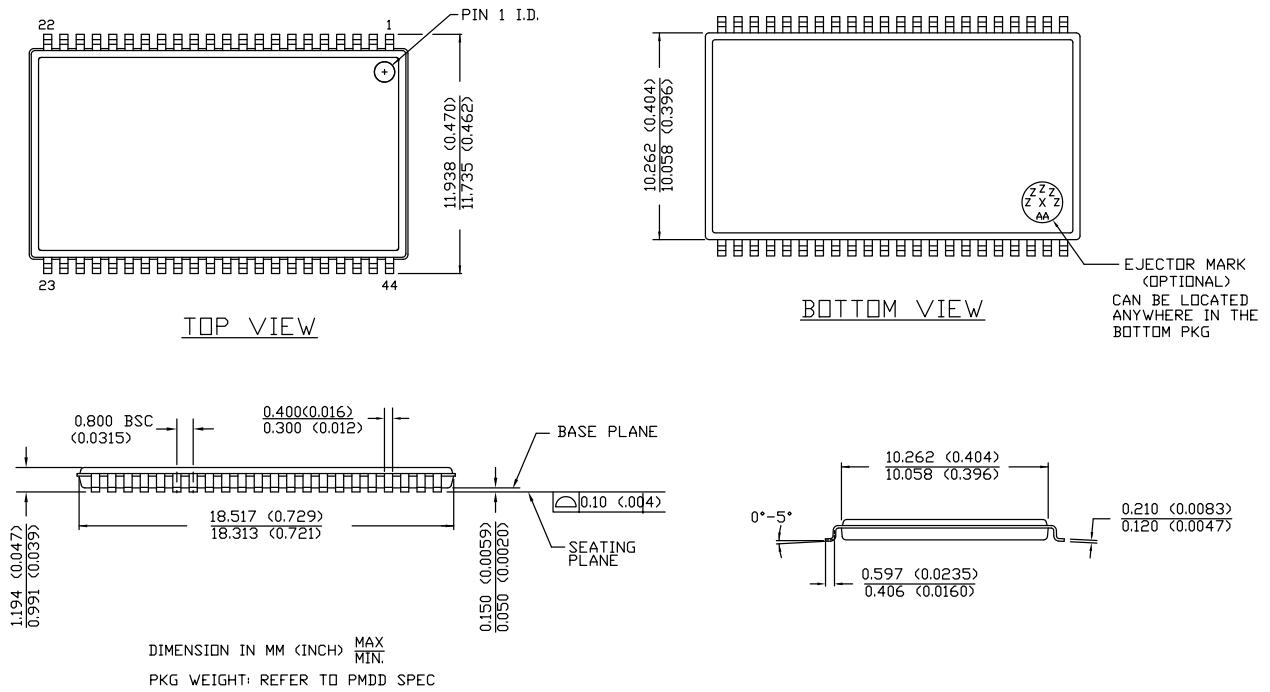
Figure 9. 36-pin SOJ V36.4 (Molded) Package Outline, 51-85090



51-85090 *F

Package Diagrams (continued)

Figure 10. 44-pin TSOP Z44-II Package Outline, 51-85087



51-85087 *E

Acronyms

| Acronym | Description |
|-----------------|---|
| \overline{CE} | Chip Enable |
| CMOS | Complementary Metal Oxide Semiconductor |
| I/O | Input/Output |
| \overline{OE} | Output Enable |
| SOJ | Small Outline J-lead |
| SRAM | Static Random Access Memory |
| TSOP | Thin Small Outline Package |
| TTL | Transistor-Transistor Logic |
| \overline{WE} | Write Enable |

Document Conventions

Units of Measure

| Symbol | Unit of Measure |
|-------------|-----------------|
| $^{\circ}C$ | degree Celsius |
| MHz | megahertz |
| μA | microampere |
| μs | microsecond |
| mA | milliampere |
| mm | millimeter |
| mW | milliwatt |
| ns | nanosecond |
| Ω | ohm |
| % | percent |
| pF | picofarad |
| V | volt |
| W | watt |

Document History Page

| Document Title: CY7C1010DV33, 2-Mbit (256 K × 8) Static RAM Document Number: 001-00062 | | | | |
|---|---------|-----------------|-----------------|--|
| Rev. | ECN No. | Submission Date | Orig. of Change | Description of Change |
| ** | 342195 | See ECN | PCI | New data sheet. |
| *A | 459073 | See ECN | NXR | Converted Preliminary to Final. Removed Commercial Operating Range from product offering. Removed -8 ns and -12 speed bin Removed the Pin definitions table. Modified Maximum Ratings for DC input voltage from -0.5V to -0.3V and V _{CC} + 0.5V to V _{CC} + 0.3V Changed I _{CC} max from 65 mA to 90 mA Changed the description of I _{LX} from "Input Load Current" to "Input Leakage Current" Updated the Thermal Resistance table. Updated footnote #7 on High-Z parameter measurement Added footnote #12 Updated the Ordering Information and replaced Package Name column with Package Diagram in the Ordering Information table. |
| *B | 2602853 | 11/07/08 | VKN / PYRS | Added 36-pin SOJ package and its related information |
| *C | 3059211 | 10/14/2010 | PRAS | Added Ordering Code Definitions . Updated Package Diagrams . |
| *D | 3272897 | 06/07/2011 | AJU | Updated Functional Description (Removed "Refer to the Cypress application note AN1064, SRAM System Guidelines for best practice recommendations."). Added Acronyms and Units of Measure . Updated in new template. |
| *E | 4207615 | 12/02/2013 | MEMJ | Updated Package Diagrams : spec 51-85090 – Changed revision from *E to *F. spec 51-85087 – Changed revision from *C to *E. Updated in new template. Completing Sunset Review. |
| *F | 4574311 | 11/19/2014 | MEMJ | Added related documentation hyperlink in page 1. |

Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at [Cypress Locations](#).

Products

| | |
|--|--|
| Automotive | cypress.com/go/automotive |
| Clocks & Buffers | cypress.com/go/clocks |
| Interface | cypress.com/go/interface |
| Lighting & Power Control | cypress.com/go/powerpsoc cypress.com/go/plc |
| Memory | cypress.com/go/memory |
| PSoC | cypress.com/go/psoc |
| Touch Sensing | cypress.com/go/touch |
| USB Controllers | cypress.com/go/USB |
| Wireless/RF | cypress.com/go/wireless |

PSoC[®] Solutions

[psoc.cypress.com/solutions](#)
[PSoC 1](#) | [PSoC 3](#) | [PSoC 4](#) | [PSoC 5LP](#)

Cypress Developer Community

[Community](#) | [Forums](#) | [Blogs](#) | [Video](#) | [Training](#)

Technical Support

[cypress.com/go/support](#)

© Cypress Semiconductor Corporation, 2005-2014. The information contained herein is subject to change without notice. Cypress Semiconductor Corporation assumes no responsibility for the use of any circuitry other than circuitry embodied in a Cypress product. Nor does it convey or imply any license under patent or other rights. Cypress products are not warranted nor intended to be used for medical, life support, life saving, critical control or safety applications, unless pursuant to an express written agreement with Cypress. Furthermore, Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress products in life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Any Source Code (software and/or firmware) is owned by Cypress Semiconductor Corporation (Cypress) and is protected by and subject to worldwide patent protection (United States and foreign), United States copyright laws and international treaty provisions. Cypress hereby grants to licensee a personal, non-exclusive, non-transferable license to copy, use, modify, create derivative works of, and compile the Cypress Source Code and derivative works for the sole purpose of creating custom software and or firmware in support of licensee product to be used only in conjunction with a Cypress integrated circuit as specified in the applicable agreement. Any reproduction, modification, translation, compilation, or representation of this Source Code except as specified above is prohibited without the express written permission of Cypress.

Disclaimer: CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS MATERIAL, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. Cypress reserves the right to make changes without further notice to the materials described herein. Cypress does not assume any liability arising out of the application or use of any product or circuit described herein. Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress' product in a life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Use may be limited by and subject to the applicable Cypress software license agreement.